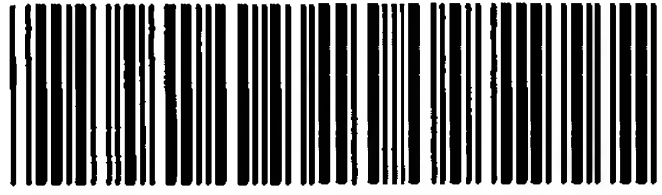


<b>Search Notes</b> 	<b>Application/Control No.</b> 10615278	<b>Applicant(s)/Patent Under Reexamination</b> DEAVER ET AL.
	<b>Examiner</b> Shan, April Y	<b>Art Unit</b> 2135

SEARCHED			
Class	Subclass	Date	Examiner
380	277, 28	8/30/2007	a.s.
	278	8/30/2007	a.s.
	37	8/30/2007	a.s.
	225	8/30/2007	a.s.
	228	8/30/2007	a.s.
	44	8/30/2007	a.s.
705	51	8/30/2007	a.s.
	59	8/30/2007	a.s.
713	193	8/30/2007	a.s.
	165	8/30/2007	a.s.
726	26	8/30/2007	a.s.

SEARCH NOTES		
Search Notes	Date	Examiner
Consult with Kim Vu (SPE 2135)	8/28/2007	a.s.
Consult with Kambiz Zand (SPE 2134) on allowable subject matter	4/12/2007	a.s.
Consult with Examiner Andrew Nalven (AU 2134) on allowable subject matter	4/13/2007	a.s.
Text search on EAST (see notes)	8/30/2007	a.s.
NPL search (ACM search)	8/30/2007	a.s.
Double patenting search by inventor name on EAST	8/30/2007	a.s.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	PUPUB and USPAT text search (See interference search print out)	8/30/2007	a.s.